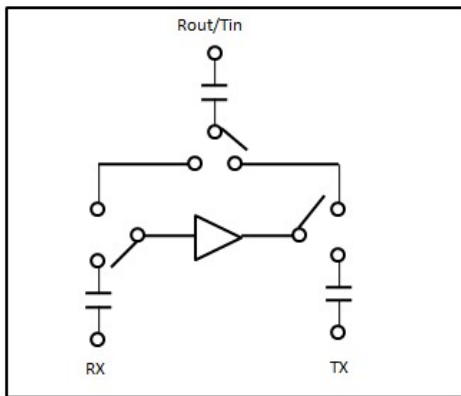


Features

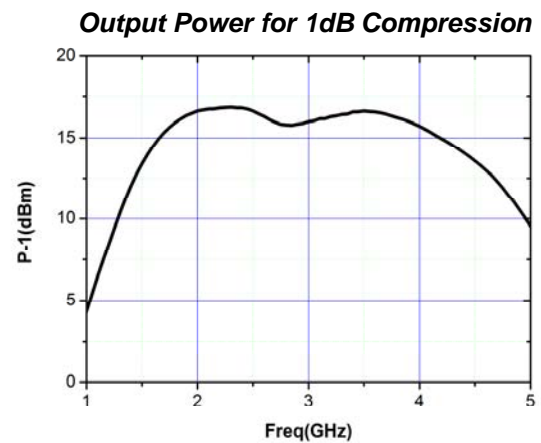
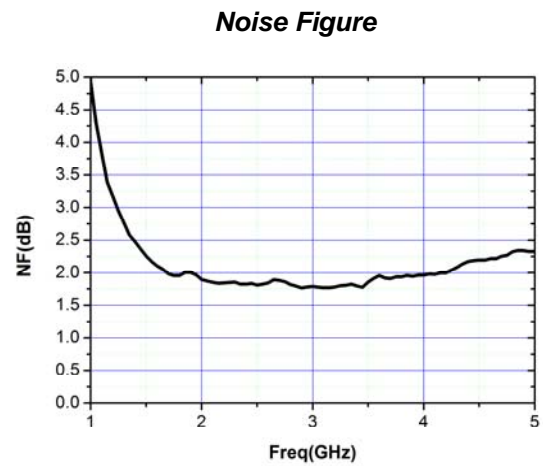
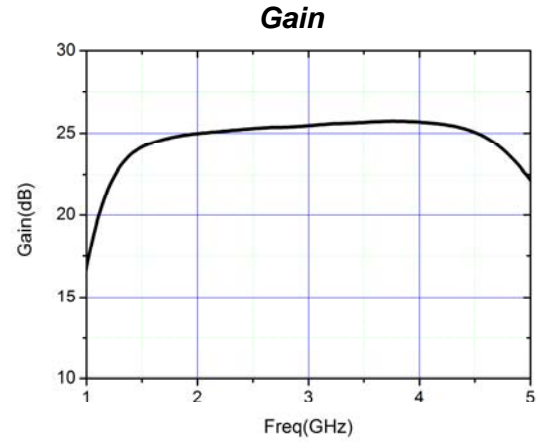
- Freq: 2~4GHz
- Gain: 25.5dB
- Noise Figure: 2dB
- Output Power for 1 dB Compression:16dBm
- Supply Voltage: +5V
- Supply Current: 80mA
- Chip Size:2.5mm×2.1mm×0.1mm

Functional Diagram

General Description

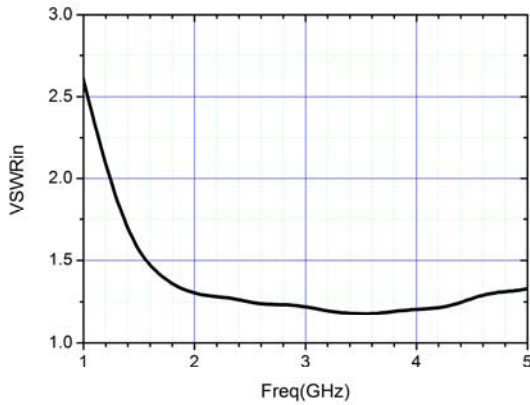
The HG113FC-1 is a GaAs pHEMT MMIC Bi-directional Amplifier operating between 2 and 4GHz. The amplifier has been optimized to provide 25.5dB gain, 2dB noise figure and 16dBm output power for 1dB compression.

Electrical Specifications($T_A=25^\circ\text{C}$, $V_{dd}= +5\text{V}$).

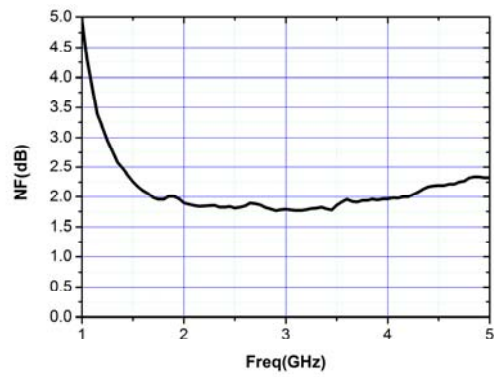
Parameter	Min.	Typ.	Max.
Freq(GHz)	2~4		
Receive Gain (dB)	—	25.5	—
Transmit Gain(dB)	—	25.5	—
Receive t VSWR	—	1.5	1.7
Transmit VSWR	—	1.5	1.8
Noise Figure(dB)	—	2	—
Output Power for 1 dB Compression(dBm)	—	16	—

Measured Performance(RX status)


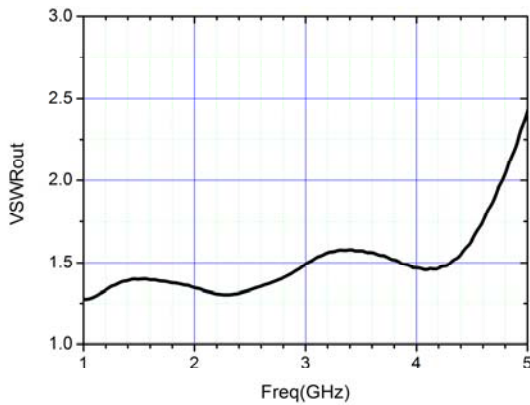
RX Input VSWR



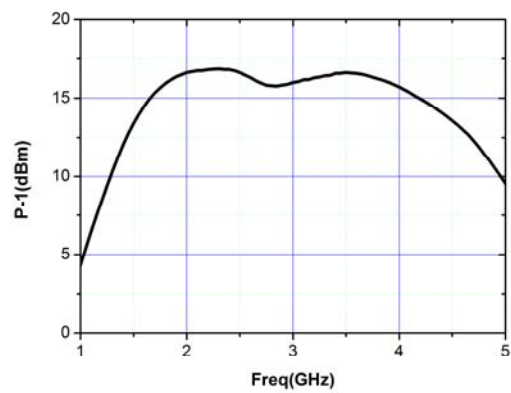
Noise Figure



RX Output VSWR

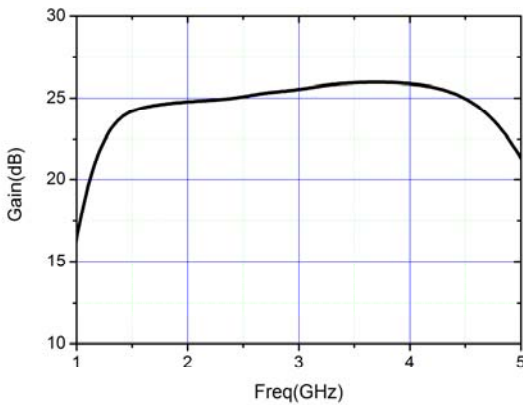


Output Power for 1dB Compression

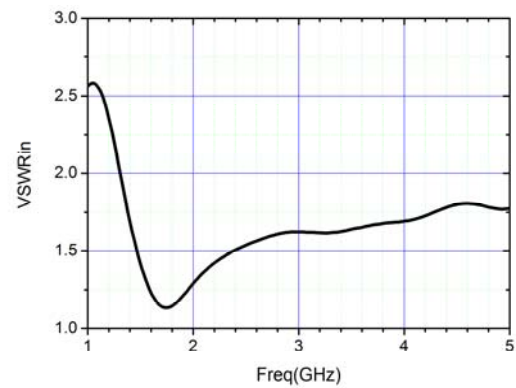


Measured Performance (TX status)

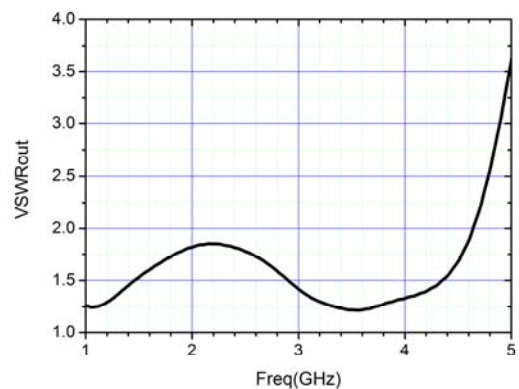
Gain

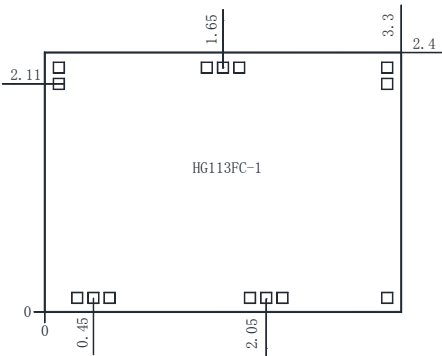
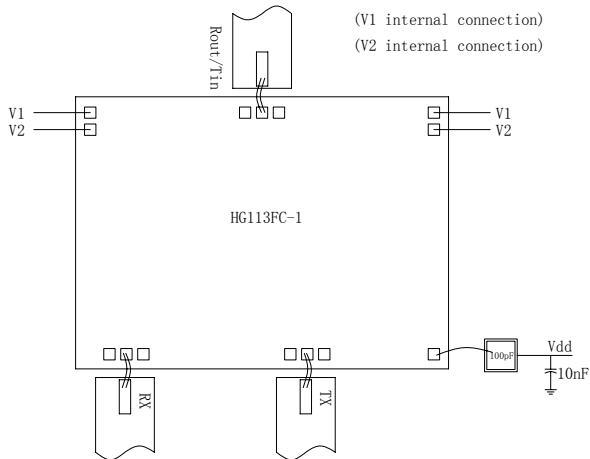


TX Input VSWR



TX Output VSWR



Outline Drawing (mm)

Assembly Diagram

Truth Table

	RF1to RF2	RF2 to RF1
RX-Rout	-5V	0
Tin-TX	0	-5V

Absolute Maximum Ratings

Supply Voltage	+5.5V
RF Input Power	+18dBm
Operating Temperature	-55°C ~ 125°C
Storage Temperature	-65°C ~ 150°C

Notes:

1. The chip should be stored in a dry and nitrogen environment, and used in a clean environment.
2. GaAs material is brittle, can not touch the surface of the chip, must be careful when using.
3. The chip is welding with conductive adhesive or alloy (alloy temperature should not exceed 300°C, and no more than 30 sec.), and should make it fully grounded.
4. The chip microwave port and substrate gap is not exceeding 0.05mm, with $\Phi 25\mu\text{m}$ double gold wire bonding, suggested length of gold wire 250~400 μm .
5. Chip microwave port with a DC blocking capacitor.
6. The chip is sensitive to static electricity, and should be protected against static electricity during storage and use.